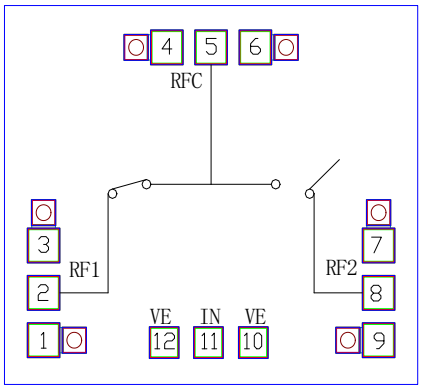
Features

·Freq: DC-20.0 GHz
·Insertion Loss: 1.1 dB
·Isolation: 50 dB
·Input Return Loss: -25dB
·On-state output return loss: -20 dB
·50Ω Input/ Output
·Die Size: 1.4×1.2×0.1mm^3

Functional Diagram



General Description

The MC1525 is a reflective SPDT switch which operates during DC-20.0 GHz.The typical insertion loss is 1.1dB and the isolation is 50dB. With 0V/+3.3V logic control, an external -5V power bias is required, the typical bias current is 2mA, and the switching speed is less than 50ns.

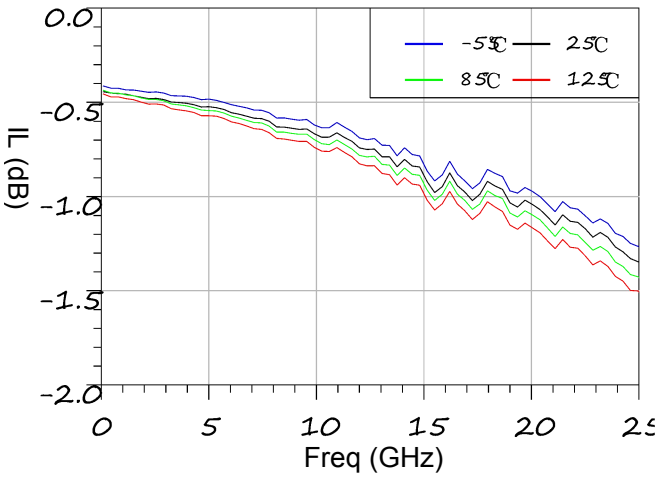
The Chip applies the on-chip metallization through-hole technology thus no need for additional grounding measures which makes it easy and convenient to use. The backside of the chip is metallized, suitable for conductive adhesive bonding or eutectic mounting process.

Electrical Specifications (TA=+25℃, 50Ω system,0V/+3.3V Control (0/+5V Control Compatible))

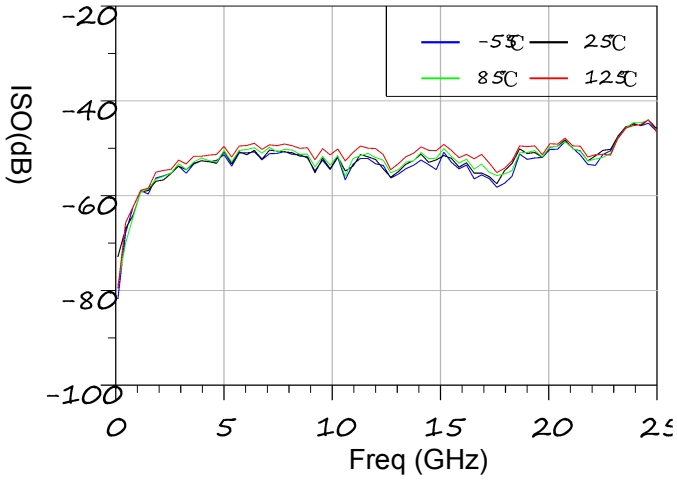
Parameter		Min.	Typ.	Max.	Unit
Frequency Range	Freq	DC	-	20.0	GHz
Insertion Loss	IL	-	1.1	-	dB
Isolation	ISO	-	50	-	dB
Input Return Loss	IRL	-	-25	-	dB
On-state output return loss	ORL	-	-20	-	dB
Switching time	T	-	-	50	ns
Bias current	I	-	2	-	mA

[1] The chips are 100% DC and RF tested.

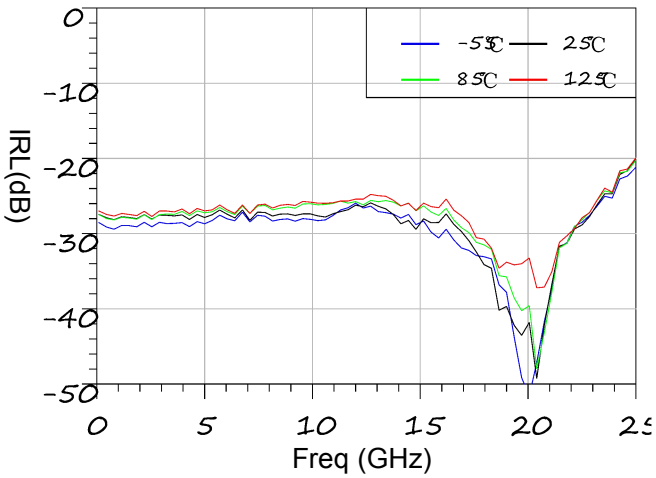
Typical Testing Characteristics



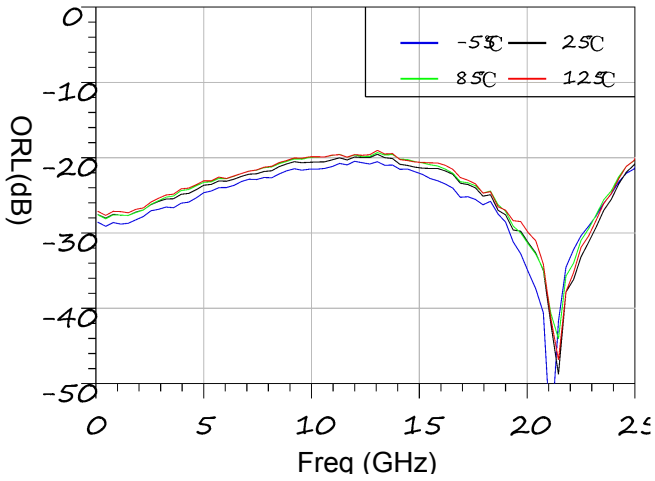
Insertion loss vs Frequency



Isolation vs Frequency



Input Return Loss vs Frequency



on-state output return loss vs Frequency

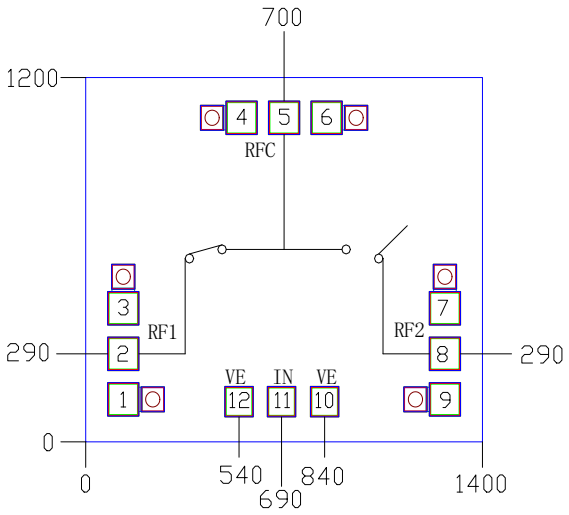
Absolute Maximum Ratings

Parameter Limits	Value
Input Power,50Ω	23dBm
Control Voltage	0V~+5V
Storage Temperature	-65~+150℃
Operating Temperature	-55~+125℃
Mounting Temperature (30s, N_2 Protection)	300℃
Exceeding the above conditions may cause permanent damage to the chip	

This product is ESD(Electrostatic discharge) sensitive. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

·Assembling in a clean environment.
·Avoiding rapid temperature changes during the mounting process.
·Do not touch the surface or use dry/wet chemical methods to clean the surface
·2 bonding wires for input and output (in figure 八), the bonding wires should be as short as possible.
·Storing in a dry, N_2 protection environment.

Outline Drawing



Notes:

1. Unit:μm
2. Back Side Metallization:Gold
3. Back side metal is ground
4. Bonding pad size: 100μm
5. Outline Dimensional Tolerance:±50 μm

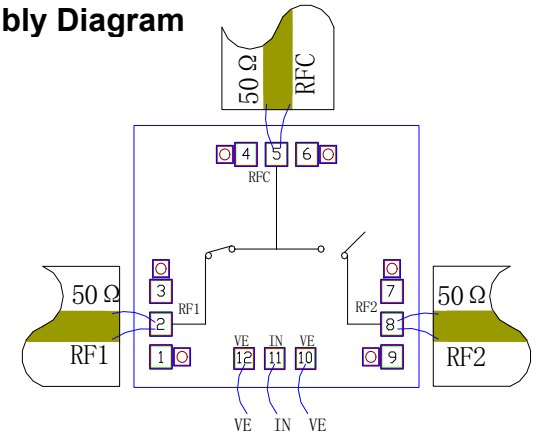
Pad Descriptions

Pad No.	Function	Description	Interface Schematic
5	RFC	RF signal input, 50Ω matched, without blocking capacitor inside	RFIN
2, 8	RFOUT	RF Signal output, 50Ω matched, without blocking capacitor inside	RFOUT
11	IN	DC control signal, 0V/+3.3V voltage matched	IN
10, 12	VE	Bias voltage, -5V voltage matched.These two VEs are connected internally, connect either of them while use	VE
1, 3, 4, 6, 7, 9	GND	Grounding pad for probe test	GND
Die Bottom	GND	Die bottom must be connected to RF/DC ground	GND

Control Voltage Range

Typ.	Control Voltage Range
0V	0V~+0.5V
+3.3V	+3V~+5V

Assembly Diagram



Control Logic

Power Voltage	Control Input	On-off state	
VE	IN	RF1	RF2
-5V	0V	ON	OFF
-5V	+3.3V	OFF	ON